

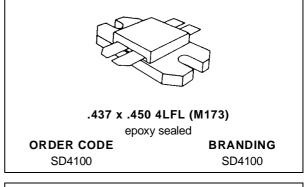
SD4100

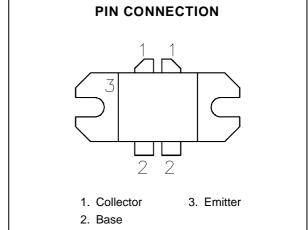
PRODUCT DEVELOPMENT DATA SHEET

This data sheet contains the design criteria and target specifications for a product which is currently under development by SGS-THOMSON. The design criteria and specifications of this item could change prior to introduction and SGS-THOMSON assumes no liability for use of information contained herein.

RF & MICROWAVE TRANSISTORS TV/LINEAR APPLICATIONS

- 470 860 MHz
- 28 VOLTS
- CLASS AB PUSH PULL
- DESIGNED FOR HIGH POWER LINEAR OPERATION
- HIGH SATURATED POWER CAPABILITY
- INTERNAL INPUT/OUTPUT MATCHING NETWORKS PROVIDE HIGH BALANCED IMPEDANCES FOR SIMPLIFIED CIRCUIT DESIGN AND WIDE INSTANTANEOUS BANDWIDTH
- GAIN = 8.5 dB MIN.
- P_{OUT} = 100 W MIN. CW
- P_{OUT} = 125 W PEAK SYNC.





DESCRIPTION

The SD4100 is a gold metallized epitaxial silicon NPN planar transistor using diffused emitter ballast resistors for high linearity Class AB operation in UHF and Band IV, V television transmitters and transposers.

ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

	,			
Symbol	Parameter	Value	Unit	
V _{CBO}	Collector-Base Voltage	65	V	
V _{CEO}	Collector-Emitter Voltage	30	V	
V _{EBO}	Emitter-Base Voltage	3.5	V	
Ic	Device Current	16	Α	
Poiss	Power Dissipation (+25°C)	220	W	
TJ	Junction Temperature	+200	°C	
T _{STG}	Storage Temperature	- 65 to +150	°C	

THERMAL DATA

R _{TH(j-c)}	Junction-Case Thermal Resistance	0.8	°C/W

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ELECTRICAL SPECIFICATIONS (T_{case} = 25°C)

STATIC

Symbol	Test Conditions		Value			Unit	
			Min.	Тур.	Max.	Oiiit	
BV _{CBO}	$I_C = 40 \text{ mA}$	$I_E = 0 \text{ mA}$		65	_	_	V
BV _{CEO}	I _C = 80 mA	$I_B = 0 \text{ mA}$		30	_	_	V
BV _{CER}	I _C = 120 mA	$R_{BE} = 75 \Omega$		40	_	_	V
BV _{EBO}	I _E = 20 mA	$I_C = 0 \text{ mA}$		3.5	_	_	V
ICEO	V _{CE} = 28 V	$I_B = 0 \text{ mA}$		_		10	mA
hfE	V _{CE} = 5 V	$I_C = 4 A$		25	_	120	

DYNAMIC

Symbol	Test Conditions		Value		
Symbol	rest Conditions	Min.	Тур.	Max.	Unit
Сов	$f=1\ MHz$ $V_{CB}=28\ V$ (each side) C_{OB} is not measurable due to Internal Output Matching Network	_	50	_	pF

DYNAMIC (CW)

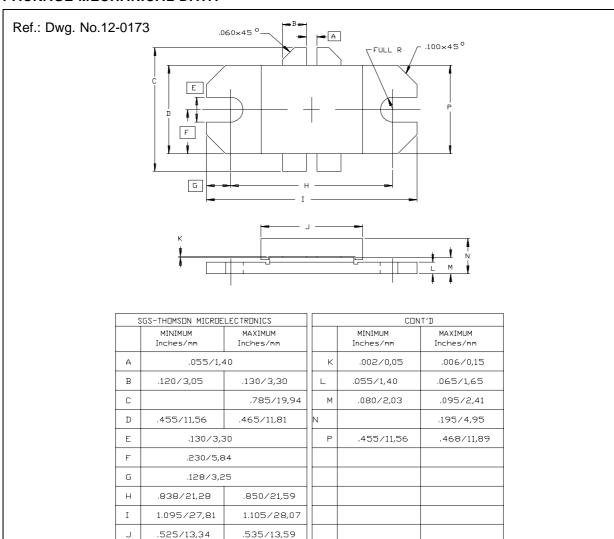
Symbol	Test Conditions		Value		Unit
Symbol	rest conditions	Min.	Тур.	Max.	Oiiit
P _{1dB}	$f = 860 \text{ MHz}$ $P_{REF} = 25 \text{ W}$ $V_{CC} = 28 \text{ V}$ $I_{CQ} = 200 \text{ mA}$	100	_	_	W
G _P	$f = 860 \text{ MHz}$ $P_{OUT} = 100 \text{ W}$ $V_{CC} = 28 \text{ V}$ $I_{CQ} = 200 \text{ mA}$	8.5	_	_	dB
ης	f = 860 MHz P _{OUT} = 100 W V _{CC} = 28 V I _{CQ} = 200 mA	55	_	_	%

DYNAMIC (Video) (Standard Black Level)

Symbol	Test Conditions				Value		Unit
Symbol				Min.	Тур.	Max.	Oiiit
G_P	f = 860 MHz	P _{OUT} = 125 W	$V_{CC} = 28 \text{ V } I_{CQ} = 200 \text{ m}$	A 8.5	_	_	dB
P _{1dB}	f = 860 MHz	P _{REF} = 25 W	$V_{CC} = 28 \text{ V } I_{CQ} = 200 \text{ m}$	A 125	_		W
P _{1dB}	f = 860 MHz	P _{REF} = 25 W	$V_{CC} = 32 \text{ V } I_{CQ} = 100 \text{ m}$	A 150	_	_	W



PACKAGE MECHANICAL DATA



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